Search Notes				

Application No.	Applicant(s)	
10/076,374	VAN DER SC	HAAR, MIHAELA
Examiner	Art Unit	
Matthew Haney	2613	

	SEARCHED		
Class	Subclass	Date	Examiner
375	240.01	10/7/2004	МЈН
375	240.20		
375 375	240,20 240,26	V	V

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
		7 A PO M (A)	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
See Attached Search History Notes	10/7/2004	МЈН
IEEE search: bitplane <and> zig zag, block <and> dct, fgs <and> block, most <and> significant <and> dct</and></and></and></and></and>	10/6/2004	MJH
IEEE search: granular <and> scalability, (bitplane <or> bit plane) <and> zigzag</and></or></and>	10/7/2004	мЈН
ACM Digital Library: scalability granular bitplane, bitplane zigzag	10/7/2004	МЈН
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